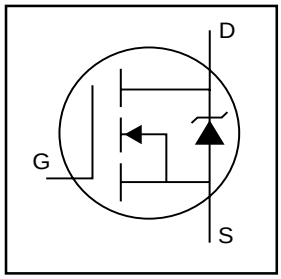
International
IOR Rectifier

PD-94072

IRFIZ48V

HEXFET® Power MOSFET

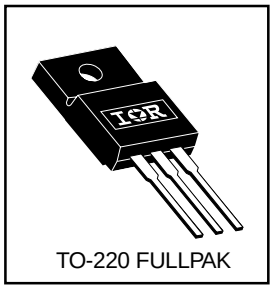
- Advanced Process Technology
- Ultra Low On-Resistance
- Isolated Package
- High Voltage Isolation = 2.5KVRMS ⑧
- Fast Switching
- Fully Avalanche Rated
- Optimized for SMPS Applications



V_{DSS} = 60V

$R_{DS(on)}$ = 12mΩ

I_D = 39A



TO-220 FULLPAK

Description

Advanced HEXFET® Power MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-220 Fullpak eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heatsink using a single clip or by a single screw fixing.

Absolute Maximum Ratings

	Parameter	Max.	Units
I_D @ T_C = 25°C	Continuous Drain Current, V_{GS} @ 10V	39	A
I_D @ T_C = 100°C	Continuous Drain Current, V_{GS} @ 10V	27	
I_{DM}	Pulsed Drain Current ①⑦	290	
P_D @T_C = 25°C	Power Dissipation	43	W
	Linear Derating Factor	0.29	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
I_{AR}	Avalanche Current①⑦	72	A
E_{AR}	Repetitive Avalanche Energy①⑦	15	mJ
dv/dt	Peak Diode Recovery dv/dt ③⑦	5.3	V/ns
T_J	Operating Junction and	-55 to + 175	°C
T_{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting torque, 6-32 or M3 srew	10 lbf•in (1.1N•m)	

Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	3.5	°C/W
$R_{\theta JA}$	Junction-to-Ambient	—	65	

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	60	—	—	V	V_{GS} = 0V, I_D = 250µA
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.064	—	V/°C	Reference to 25°C, I_D = 1mA ⑦
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	12.0	mΩ	V_{GS} = 10V, I_D = 43A ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0	—	4.0	V	V_{DS} = V_{GS}, I_D = 250µA
g_{fs}	Forward Transconductance	35	—	—	S	V_{DS} = 25V, I_D = 43A④⑦
I_{DSS}	Drain-to-Source Leakage Current	—	—	25	µA	V_{DS} = 60V, V_{GS} = 0V
		—	—	250		V_{DS} = 48V, V_{GS} = 0V, T_J = 150°C
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	V_{GS} = 20V
	Gate-to-Source Reverse Leakage	—	—	-100		V_{GS} = -20V
Q_g	Total Gate Charge	—	—	110	nC	I_D = 72A
Q_{gs}	Gate-to-Source Charge	—	—	29		V_{DS} = 48V
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	36		V_{GS} = 10V, See Fig. 6 and 13 ④⑦
$t_{d(on)}$	Turn-On Delay Time	—	7.6	—	ns	V_{DD} = 30V
t_r	Rise Time	—	200	—		I_D = 72A
$t_{d(off)}$	Turn-Off Delay Time	—	157	—		R_G = 9.1Ω
t_f	Fall Time	—	166	—		R_D = 0.34Ω, See Fig. 10 ④⑦
L_D	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact
L_S	Internal Source Inductance	—	7.5	—		
C_{iss}	Input Capacitance	—	1985	—	pF	V_{GS} = 0V
C_{oss}	Output Capacitance	—	496	—		V_{DS} = 25V
C_{rss}	Reverse Transfer Capacitance	—	91	—		f = 1.0MHz, See Fig. 5 ⑦
E_{as}	Single Pulse Avalanche Energy ②⑦	—	780⑤	170⑥	mJ	I_{AS} = 72A, L = 64mH

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	39	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode)①⑦	—	—	290		
V_{SD}	Diode Forward Voltage	—	—	2.0	V	T_J = 25°C, I_S = 72A, V_{GS} = 0V ④⑦
t_{rr}	Reverse Recovery Time	—	70	100	ns	T_J = 25°C, I_F = 72A
Q_{rr}	Reverse Recovery Charge	—	155	233	nC	di/dt = 100A/µs ④⑦
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

② Starting T_J = 25°C, L = 64µH
R_G = 25Ω, I_{AS} = 72A. (See Figure 12)

③ I_{SD} ≤ 72A, di/dt ≤ 151A/µs, V_{DD} ≤ $V_{(BR)DSS}$, T_J ≤ 175°C

④ Pulse width ≤ 300µs; duty cycle ≤ 2%.

⑤ This is a typical value at device destruction and represents operation outside rated limits.

⑥ This is a calculated value limited to T_J = 175°C .

⑦ Uses IRFZ48V data and test conditions.

⑧ t = 60s, f = 60Hz

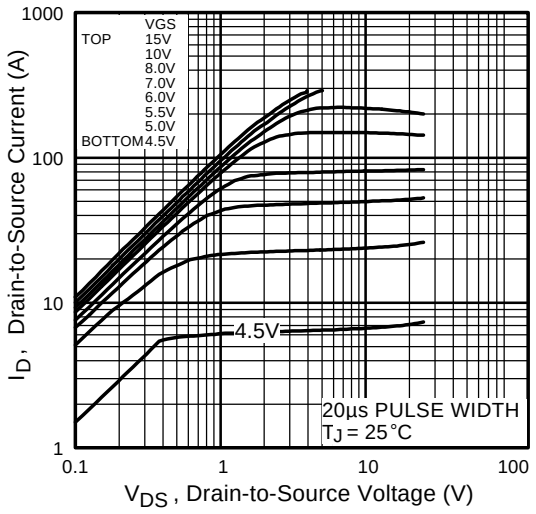


Fig 1. Typical Output Characteristics

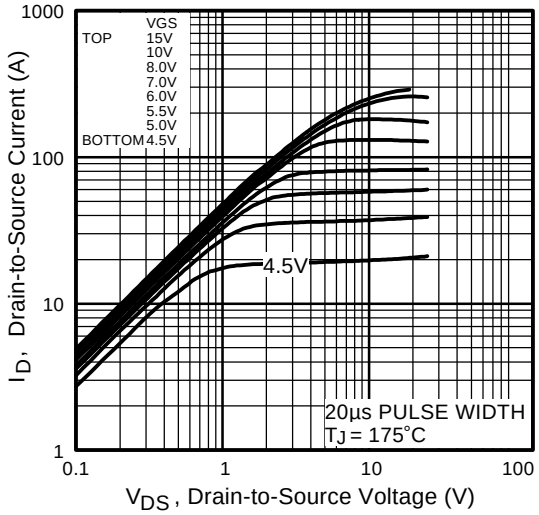


Fig 2. Typical Output Characteristics

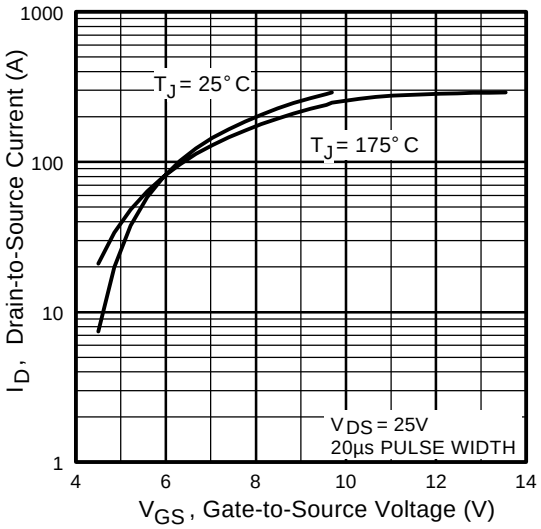


Fig 3. Typical Transfer Characteristics

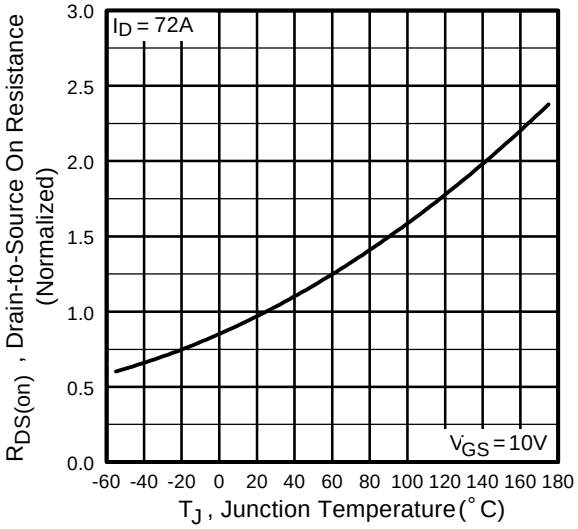


Fig 4. Normalized On-Resistance Vs. Temperature

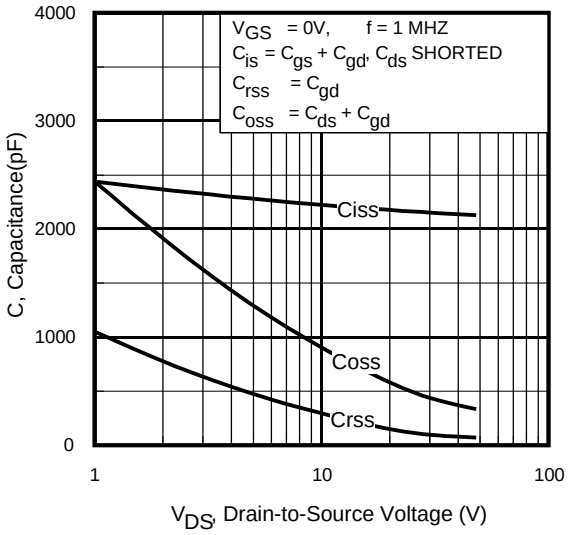


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

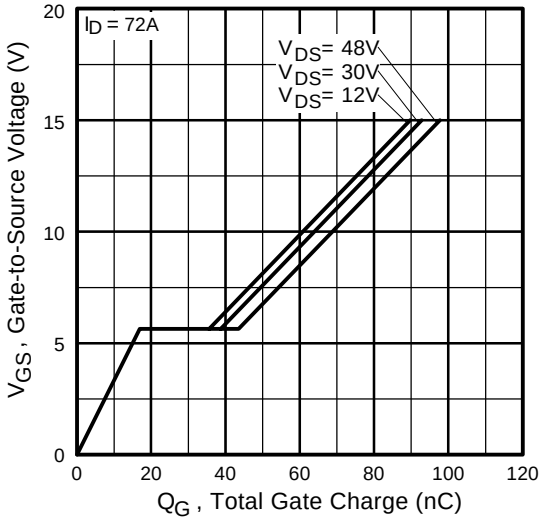


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

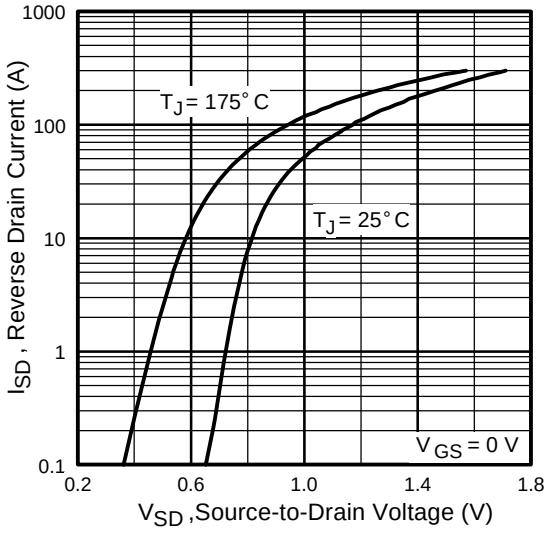


Fig 7. Typical Source-Drain Diode Forward Voltage

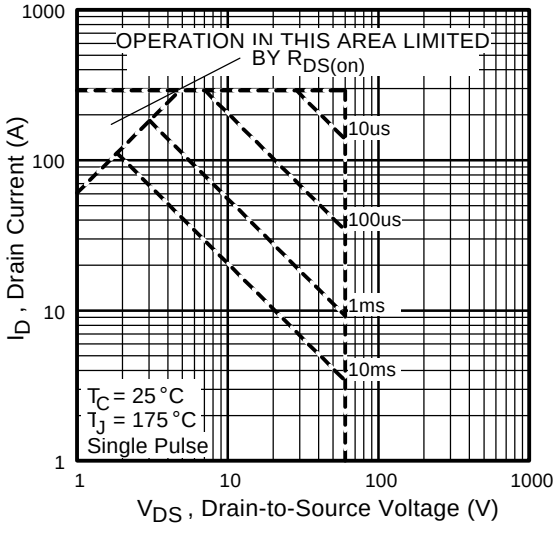


Fig 8. Maximum Safe Operating Area

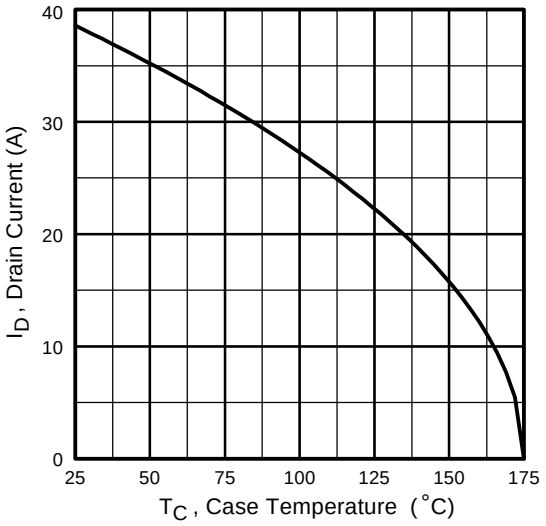


Fig 9. Maximum Drain Current Vs. Case Temperature

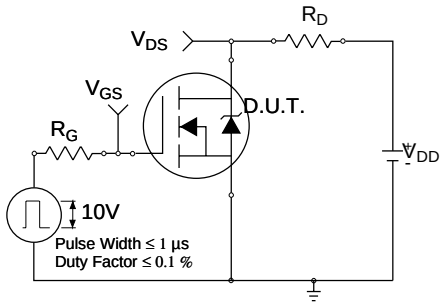


Fig 10a. Switching Time Test Circuit

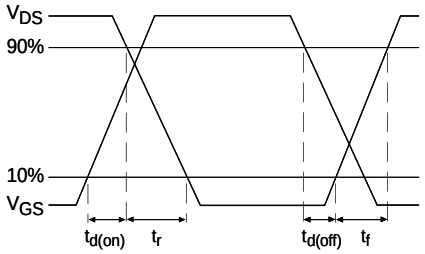


Fig 10b. Switching Time Waveforms

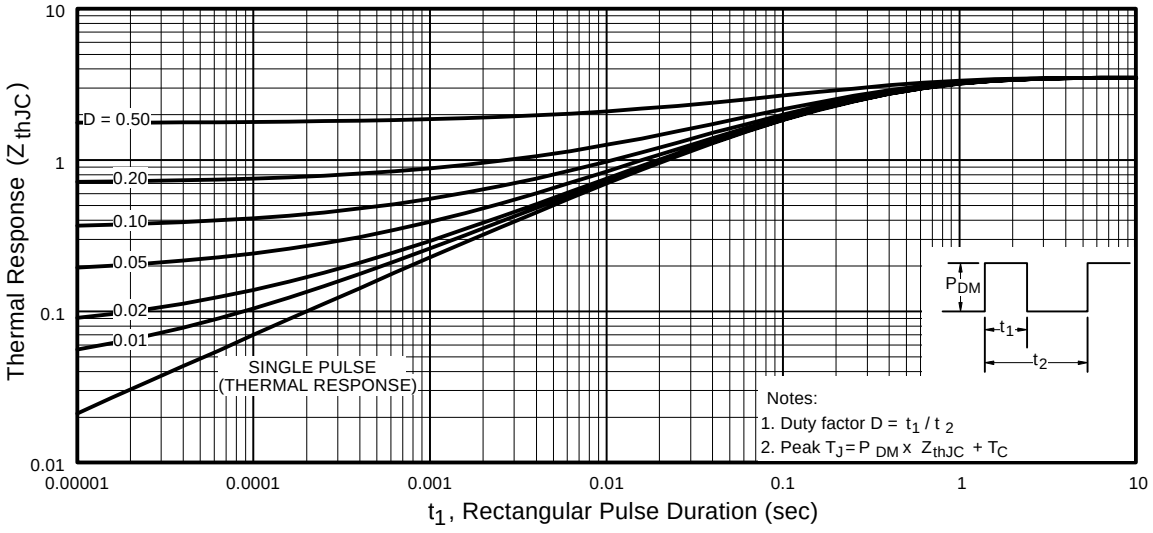


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

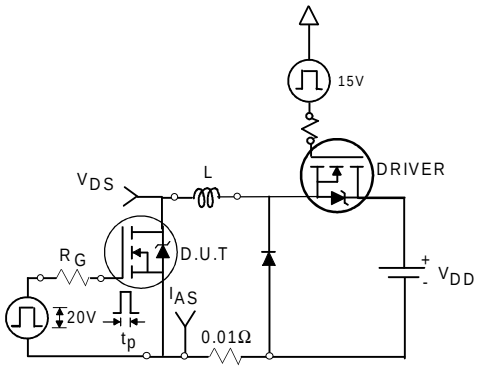


Fig 12a. Unclamped Inductive Test Circuit

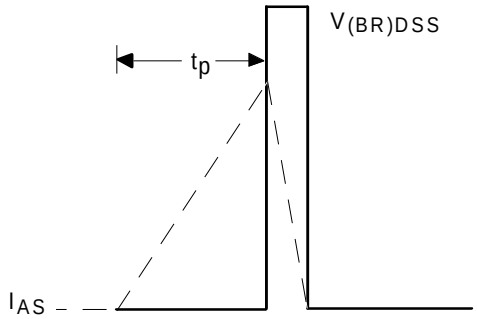


Fig 12b. Unclamped Inductive Waveforms

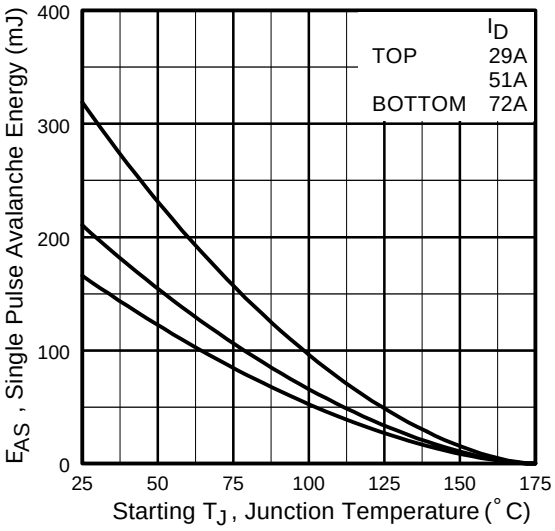


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

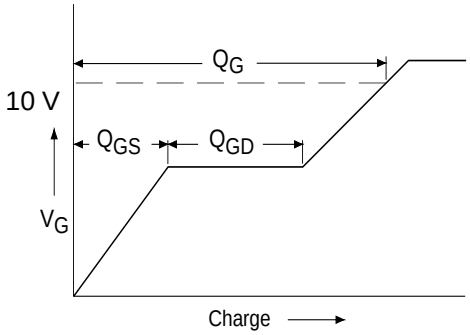


Fig 13a. Basic Gate Charge Waveform

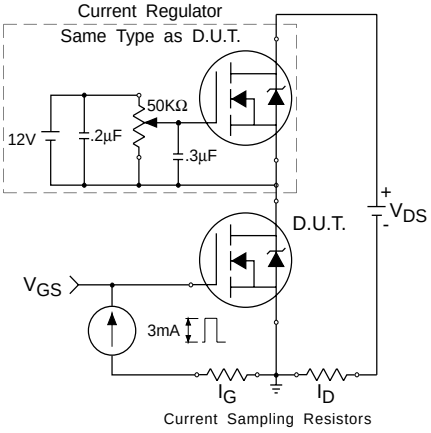
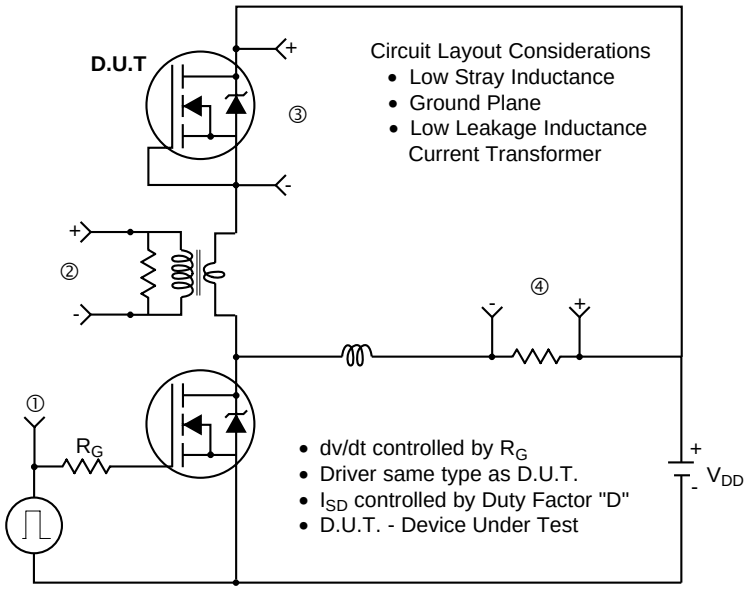
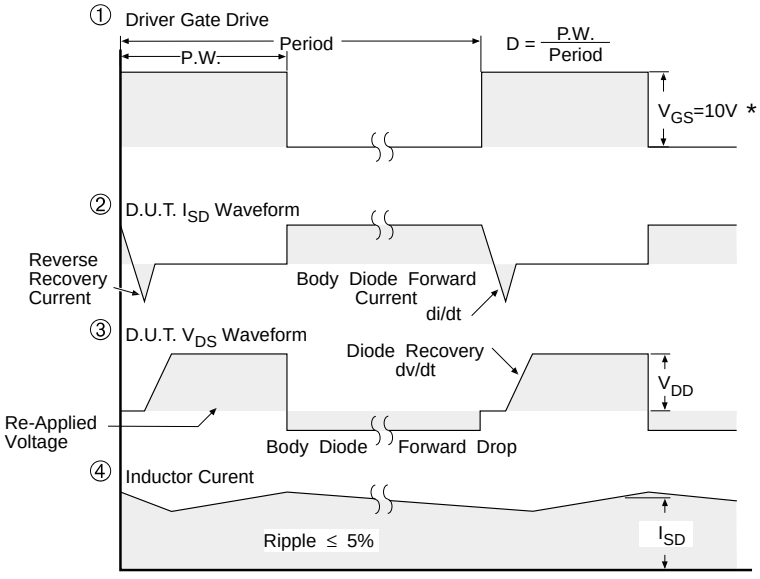


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit





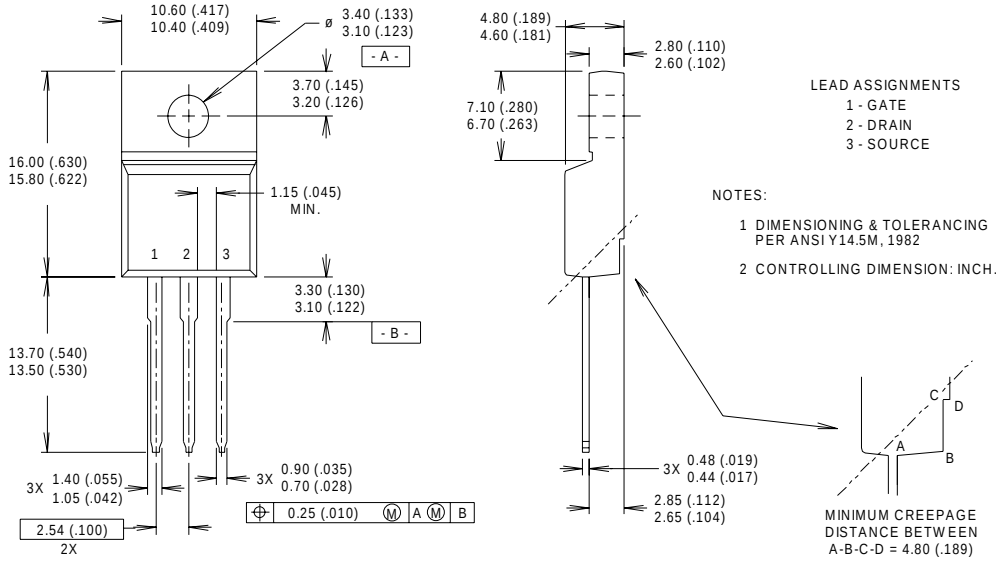
* V_{GS} = 5V for Logic Level Devices

Fig 14. For N-Channel HEXFETS® Power MOSFETS

Package Outline

TO-220 Fullpak Outline

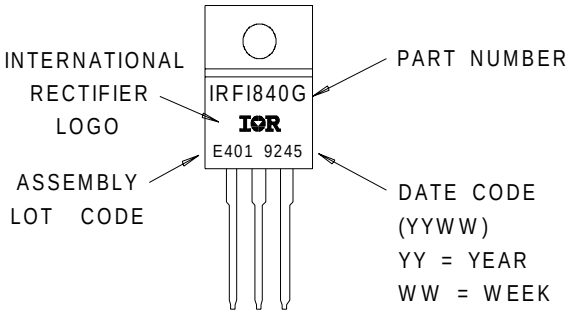
Dimensions are shown in millimeters (inches)



Part Marking Information

TO-220 Fullpak

EXAMPLE : THIS IS AN IRFI840G
WITH ASSEMBLY
LOT CODE E401



Data and specifications subject to change without notice.
This product has been designed and qualified for the industrial market.
Qualification Standards can be found on IR's Web site.

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